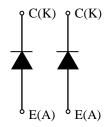
#### **FEATURES**

- \* Low Reverse Recovery Loss diode module.
- \* Low noise recovery: Ultra soft fast recovery diode.
- \* High reverse recovery capability: Super HiRC Structure.
- \* High reliability, high durability diodes.
- \* Isolated heat sink (terminal to base).

#### **CIRCUIT DIAGRAM**



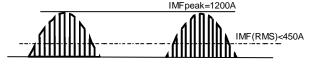
### **ABSOLUTE MAXIMUM RATINGS (TC=25°C)**

Item			Symbol	Unit	MDM1200H45E2-H
Repetitive Peak Reverse Voltage			V <sub>RRM</sub>	V	4,500
Forward Current  AC peak 1ms		I <sub>MFpeak</sub>	Α	1,200	
		1ms	<b>I</b> Fpulse	^	2,400
Junction Temperature			Tj	လွ	-40 ∼ +125
Maximum Junction Temperature			T <sub>vj max</sub>	သိ	150 (1)
Storage Temperature			Tstg	လွ	-50 ∼ +125 (2)
Isolation Test Terminal		base	$V_{ISO}$	$V_{RMS}$	10,200 (AC 1 minute)
Voltage	Terminal 1	-Terminal 2	V <sub>ISO T-T</sub>	V RMS	10,200 (AC 1 minute)
Screw Torque	Terminals		-	N∙m	10 (3)
	Mounting (	M6)	-	14.111	6 (4)

Notes: (1) Regarding the definition of T<sub>vj max</sub> for each operation mode, please refer to LD-ES-130737. (2) Terminal temperature shall not exceed the specified temperature in any operation.

(3) Recommended Value 9±1N·m

(4) Recommended Value 5.5±0.5N⋅m



#### **ELECTRICAL CHARECTERISTICS**

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions
Repetitive Reverse Current	I <sub>RRM</sub>	mΑ	ı	2.0	25	VAK=4,500V, Tj=125°C
Forward Voltage Drop	VF	V	-	4.2	4.7	IF=1,200A, Tj=125°C
Reverse Recovery Time	trr	μS	1	0.9	1.8	Vcc=2,600V, IF=1,200A, Ls=180nH
Reverse Recovery Loss	E <sub>rr(10%)</sub>	J/P	-	2.7	4.0	Tj=125°C Rg=3.3 Ω (5)

Notes:(5) Counter arm; MBN1200H45E2-H VGE=+/-15V

R<sub>g</sub> value is the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable R<sub>g</sub> value after the measurement of switching waveforms

(overshoot voltage, etc.) with appliance mounted.

#### **PACKAGE CHARECTERISTICS**

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Terminal Resistance	RCE	$m\Omega$	-	0.3	-	per arm	
Terminal Stray Inductance	Lsce	nΗ	-	42	-	per arm	
Thermal Impedance	Rth(j-c)	K/W	-	-	0.017	Junction to case (per arm)	
Comparative tracking index	CTI		-	600	-		
Contact Thermal Impedance	Rth(c-f)	K/W	-	0.007	-	Case to fin (λgrease=1W/(m⋅K), Heat-sink flatness ≤50um)	

<sup>\*</sup> Please contact our representatives at order.



<sup>\*</sup> For improvement, specifications are subject to change without notice.

<sup>\*</sup> For actual application, please confirm this spec sheet is the newest revision.

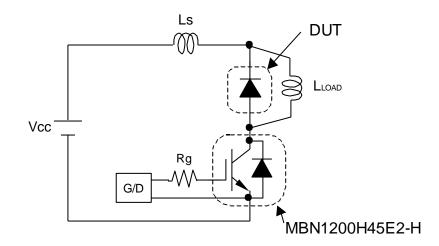


Fig.1 Switching test circuit

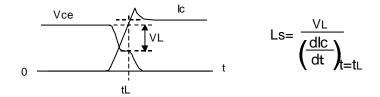


Fig.2 Definition of stray inductance

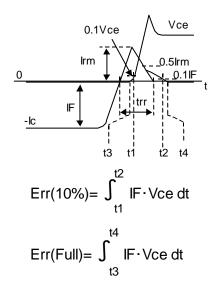
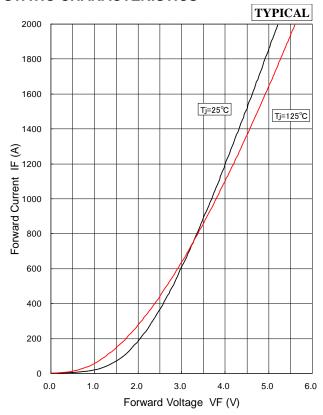


Fig.3 Definition of switching loss

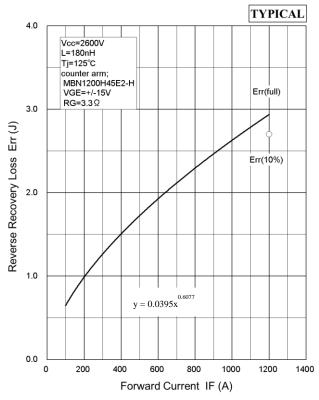


### STATIC CHARACTERISTICS

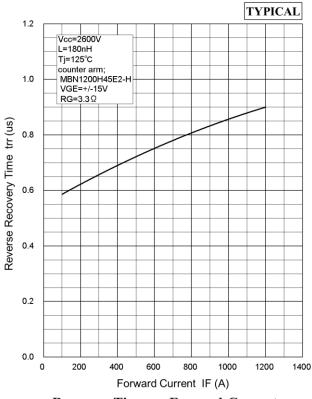


Forward Voltage of diode

### **DYNAMIC CHARACTERISTICS**

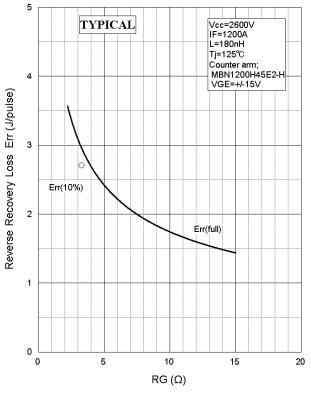


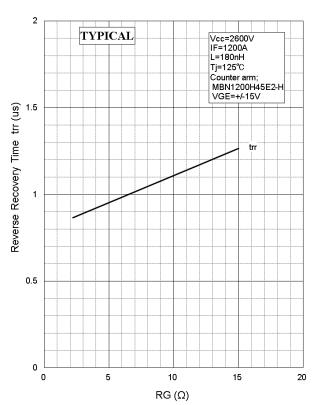
**Recovery Loss vs. Forward Current** 



**Recovery Time vs. Forward Current** 



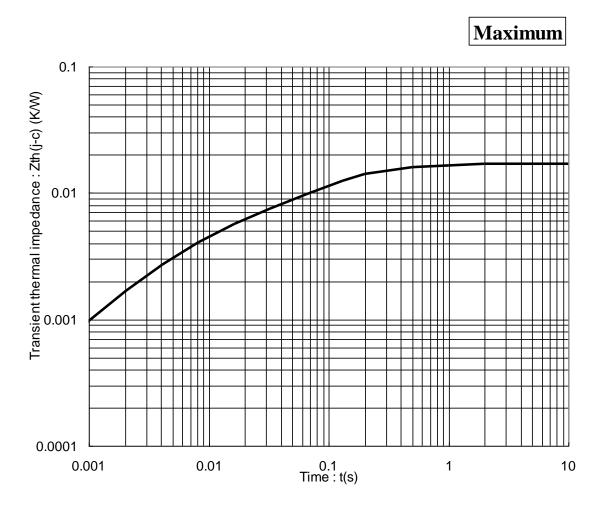




Recovery Loss vs. RG

Recovery Time vs. RG

#### TRANSIENT THERMAL IMPEDANCE



### **Transient Thermal Impedance Curve**

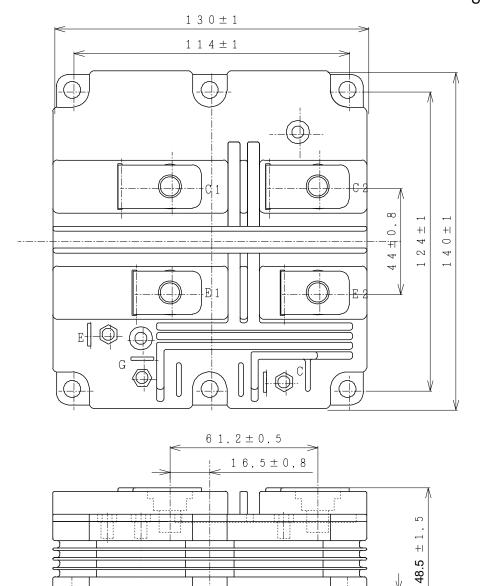
### Curve Approximation Model Σ rth[n]\*(1-exp(-t/τth[n]))

n	1	2	3	4	Unit
т th[n]	3.98E-01	6.81E-02	1.32E-02	3.16E-04	sec
rth[n,Diode]	1.02E-02	3.35E-03	3.18E-03	2.87E-04	K/W



#### **OUTLINE DRAWING**

Unit in mm



Weight: 1050(g)

#### Material declaration

Please note the following materials are contained in the product in order to keep product characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder



### HITACHI POWER SEMICONDUCTORS

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